

Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/613,332	LEE ET AL.
Examiner	Art Unit	
Mark K. Han	3767	

ORIGINAL				CROSS REFERENCE(S)							
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
604		96.01		606	194						
INTERNATIONAL CLASSIFICATION				428	36.9						
A	6	1	M	29/00							
B	2	9	C	47/00							
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<i>Mark</i> Mark K Han 3/16/06 (Assistant Examiner) (Date)				MICHAEL J. HAYES PRIMARY EXAMINER <i>Michael Hayes</i> 3/20/06 (Primary Examiner) (Date)				Total Claims Allowed: <i>18</i>			
<i>Lee</i> 3-21-06 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s)	O.G. Print Fig.		
								1	1		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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